of 1984 as amended by Pub. L. 104–295, which pertains solely to the application described below. Related records can be viewed between 8:30 a.m. and 5:00 p.m. in Room 4211, U.S. Department of Commerce, 14th and Constitution Avenue, N.W., Washington, D.C.

Applicant: University of Arizona, Steward Observatory, Tucson, AZ 85721. Instrument: Submillimeter Bolometer, Receivers, Acoustical Optical Spectrometer, Spectrometers and other custom equipment to support a submillimeter telescope. Manufacturer: Max Planck Institute, Germany. Intended Use: See notice at 62 FR 33603, June 20, 1997.

Comments: None received. Decision: Approved. No instruments of equivalent scientific value to the foreign instruments for such purposes as the instruments are intended to be used, are being manufactured in the United States. Reasons: These are compatible accessories for an existing instrument purchased for the use of the applicant.

We know of no domestic accessories which can be readily adapted to the existing instrument.

Frank W. Creel,

Director, Statutory Import Programs Staff. [FR Doc. 97–20384 Filed 7–31–97; 8:45 am] BILLING CODE 3510–DS–P

DEPARTMENT OF COMMERCE

International Trade Administration

The University of Houston, et al.; Notice of Consolidated Decision on Applications for Duty-Free Entry of Electron Microscopes

This is a decision consolidated pursuant to Section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89–651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 a.m. and 5:00 p.m. in Room 4211, U.S. Department of Commerce, 14th and Constitution Avenue, N.W., Washington, D.C.

Docket Number: 97–042. Applicant: The University of Houston, Houston, TX 77204. Instrument: Electron Microscope, Model JEM–2010F. Manufacturer: JEOL, Ltd., Japan. Intended Use: See notice at 62 FR 32766, June 17, 1997. Order Date: March 3, 1997.

Docket Number: 97–045. Applicant: Baylor University, Waco, TX 76798– 7088. Instrument: Electron Microscope, Model JEM–1010. Manufacturer: JEOL, Ltd., Japan. Intended Use: See notice at 62 FR 32766, June 17, 1997. Order Date: March 24, 1997. Docket Number: 97–048. Applicant: Kansas State University, Manhattan, KS 66506–4901. Instrument: Electron Microscope, Model CM100. Manufacturer: Philips, The Netherlands. Intended Use: See notice at 62 FR 34691, June 27, 1997. Order Date: March 27, 1997.

Comments: None received. Decision: Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as these instruments are intended to be used, was being manufactured in the United States at the time the instruments were ordered. Reasons: Each foreign instrument is a conventional transmission electron microscope (CTEM) and is intended for research or scientific educational uses requiring a CTEM. We know of no CTEM, or any other instrument suited to these purposes, which was being manufactured in the United States at the time of order of each instrument.

Frank W. Creel,

Director, Statutory Import Programs Staff. [FR Doc. 97–20385 Filed 7–31–97; 8:45 am] BILLING CODE 3510–DS–P

DEPARTMENT OF COMMERCE

International Trade Administration

University of Wisconsin, et al.; Notice of Consolidated Decision on Applications for Duty-Free Entry of Scientific Instruments

This is a decision consolidated pursuant to Section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89–651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 A.M. and 5:00 P.M. in Room 4211, U.S. Department of Commerce, 14th and Constitution Avenue, N.W., Washington, D.C.

Comments: None received. Decision: Approved. No instrument of equivalent scientific value to the foreign instruments described below, for such purposes as each is intended to be used, is being manufactured in the United States.

Docket Number: 97–040. Applicant: University of Wisconsin, Madison, WI 53706. Instrument: Ti:Sapphire Laser, Model MBR–110. Manufacturer: Microlase Optical Systems, United Kingdom. Intended Use: See notice at 62 FR 32296, June 13, 1997. Reasons: The foreign instrument provides: (1) a line length less than 100 kH, (2) scan length of 0–30 GHz (digitally controlled) and (3) scan time of 5–4000 seconds (digitally controlled).

Docket Number: 97–044. Applicant: University of Rochester, Rochester NY 14627. Instrument: (2) ICP Mass Spectrometers, Model Plasma 54. Manufacturer: VG Elemental, United Kingdom. Intended Use: See notice at 62 FR 32766, June 17, 1997. Reasons: The foreign instrument provides a double-focussing magnetic sector analyzer with 9 Faraday collectors with precision less than 0.003%.

The capabilities of each of the foreign instruments described above are pertinent to each applicant's intended purposes. We know of no instrument or apparatus being manufactured in the United States which is of equivalent scientific value to either of the foreign instruments.

Frank W. Creel,

Director, Statutory Import Programs Staff. [FR Doc. 97–20386 Filed 7–31–97; 8:45 am] BILLING CODE 3510–DS-P

DEPARTMENT OF COMMERCE

International Trade Administration

Applications for Duty-Free Entry of Scientific Instruments

Pursuant to Section 6(c) of the Educational, Scientific and Cultural Materials Importation Act of 1966 (Pub. L. 89–651; 80 Stat. 897; 15 CFR part 301), we invite comments on the question of whether instruments of equivalent scientific value, for the purposes for which the instruments shown below are intended to be used, are being manufactured in the United States.

Comments must comply with 15 CFR 301.5(a) (3) and (4) of the regulations and be filed within 20 days with the Statutory Import Programs Staff, U.S. Department of Commerce, Washington, D.C. 20230. Applications may be examined between 8:30 A.M. and 5:00 P.M. in Room 4211, U.S. Department of Commerce, 14th Street and Constitution Avenue, N.W., Washington, D.C.

Docket Number: 96–104R. Applicant: University of Georgia, D W Brooks Drive, Warnell School of Forest Resources, Building #4, Room 102, Athens, GA 30602. Instrument: Environmental Process Control Laboratory. Manufacturer: Minworth Systems Ltd., United Kingdom. Intended Use: Original notice of this resubmitted application was published in the Federal Register of October 30, 1996.

Docket Number: 97–054. Applicant: City College of New York, 140th Street and Convent Avenue, Room 165, New York, NY 11235. Instrument: Rapid